STEALTH Diode 30 A, 300 V

FFH30US30DN

Description

The FFH30US30DN is a STEALTH $^{\text{\tiny M}}$ diode optimized for low loss performance in output rectification. The STEALTH family exhibits low reverse recovery current ($I_{RM(REC)}$), low V_F and soft recovery under typical operating conditions.

This device is intended for use as an output rectification diode in Telecom power supplies and other power switching applications. Lower V_F and $I_{RM(REC)}$ reduces diode losses.

Formerly developmental type TA49449.

Features

• Soft Recovery $t_b/t_a > 0.45$ • Fast Recovery trr < 50 ns• High Operating Temperature 175°C • Reverse Voltage 300 V• Avalanche Energy Rating 20 mJ• This is a Pb-Free Device

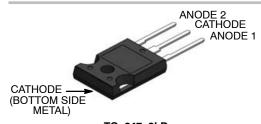
Applications

- Switch Mode Power Supplies
- Power Factor Correction
- Uninterruptable Power Supplies
- Motor Drives
- Welders

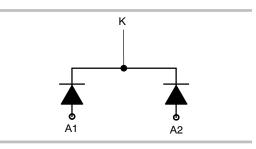


ON Semiconductor®

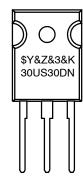
www.onsemi.com



TO-247-3LD CASE 340CK



MARKING DIAGRAM



\$Y = ON Semiconductor Logo &Z = Assembly Plant Code &3 = Numeric Date Code &K = Lot Code 30US30DN = Specific Device Code

ORDERING INFORMATION

See detailed ordering and shipping information on page 2 of this data sheet.

DEVICE MAXIMUM RATINGS (per leg) (T_C = 25°C unless otherwise noted)

Rating	Symbol	Value	Unit
Repetitive Peak Reverse Voltage	V_{RRM}	300	V
Working Peak Reverse Voltage	V_{RWM}	300	V
DC Blocking Voltage	V_{R}	300	V
Average Rectified Forward Current (T _C = 160°C)	I _{F(AV)}	30	Α
Total Device Current (Both Legs)		60	
Repetitive Peak Surge Current (20 kHz Square Wave)	I _{FRM}	70	Α
Non-repetitive Peak Surge Current (Halfwave 1 Phase 60 Hz)	I _{FSM}	325	Α
Power Dissipation	P_{D}	230	W
Avalanche Energy (1 A, 40 mH)	E _{AVL}	20	mJ
Operating and Storage Temperature Range	T _J , T _{STG}	-55 to 175	°C
Maximum Temperature for Soldering Leads at 0.063in (1.6 mm) from Case for 10 s Package Body for 10 s, See Application Note AN-7528	T _L T _{PKG}	300 260	°C °C

Stresses exceeding those listed in the Maximum Ratings table may damage the device. If any of these limits are exceeded, device functionality should not be assumed, damage may occur and reliability may be affected.

THERMAL CHARACTERISTICS ($T_C = 25^{\circ}C$ unless otherwise noted)

Parameter	Symbol	Max	Unit
Thermal Resistance, Junction to Case	$R_{ heta JC}$	0.65	°C/W
Thermal Resistance, Junction to Ambient	$R_{\theta JA}$	30	°C/W

PACKAGE MARKING AND ORDERING INFORMATION

Device	Device Marking	Package	Tape Width	Quantity
FFH30US30DN	30US30DN	TO-247-3LD	N/A	30

ELECTRICAL CHARACTERISTICS ($T_J = 25^{\circ}C$ unless otherwise noted)

Parameter	Symbol	Test Condition		Min	Тур	Max	Unit
OFF STATE CHARACTERISTICS	•				•	•	•
Instantaneous Reverse Current	I _R	V _R = 300 V	T _C = 25°C	-	-	100	μΑ
			T _C = 125°C	_	-	1	mA
ON STATE CHARACTERISTICS							
Instantaneous Forward Voltage	V _F	I _F = 30 A	T _C = 25°C	-	0.93	1.0	V
			T _C = 125°C	_	0.8	0.87	1
DYNAMIC CHARACTERISTICS		•					
Junction Capacitance	CJ	V _R = 10 V, I _F = 0 A		-	410	_	pF
SWITCHING CHARACTERISTICS		•					
Reverse Recovery Time	t_{rr} $I_F = 1 \text{ A, } dI_F/dt = 100 \text{ A/}\mu\text{s, V}_R = 15 \text{ V}$		-	29	50	ns	
		$I_F = 30 \text{ A}, dI_F/dt = 100 \text{ A}/\mu\text{s}, V_R = 15 \text{ V}$		-	32	55	1
Reverse Recovery Time	t _{rr}	$I_F = 30 \text{ A},$ $dI_F/dt = 200 \text{ A}/\mu\text{s},$ $V_R = 195 \text{ V},$ $T_C = 25^{\circ}\text{C}$		-	46	_	ns
Maximum Reverse Recovery Current	I _{RM(REC)}			-	5.3	_	Α
Reverse Recovered Charge	Q _{RR}			-	140	_	nC
Reverse Recovery Time	t _{rr}	I _F = 30 A		-	77	_	ns
Softness Factor (t _b /t _a)	S	dI _F /dt = 200 A/μs V _R = 195 V, T _C = 125°C		-	0.45	_	-
Maximum Reverse Recovery Current	I _{RM(REC)}			-	9	_	Α
Reverse Recovered Charge	Q _{RR}			-	400	-	nC
Reverse Recovery Time	t _{rr}	I _F = 30 A dI _F /dt = 1000 A/μs V _R = 195 V, T _C = 125°C		-	54	_	ns
Softness Factor (t _b /t _a)	S			-	0.49	_	-
Maximum Reverse Recovery Current	I _{RM(REC)}			-	32	_	Α
Reverse Recovered Charge	Q _{RR}			-	930	_	nC

Product parametric performance is indicated in the Electrical Characteristics for the listed test conditions, unless otherwise noted. Product performance may not be indicated by the Electrical Characteristics if operated under different conditions.

TYPICAL PERFORMANCE CURVES (per leg)

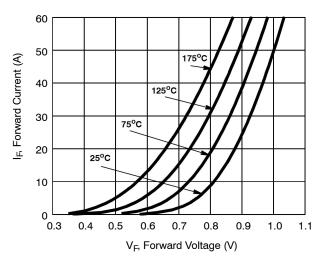


Figure 1. Forward Current vs. Forward Voltage

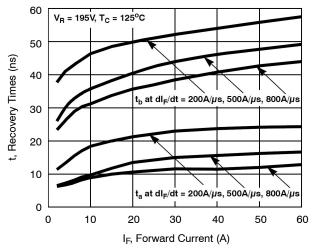


Figure 3. t_a and t_b Curves vs. Forward Current

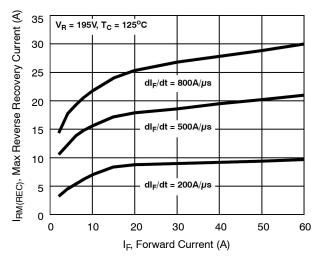


Figure 5. Maximum Reverse Recovery Current vs. Forward Current

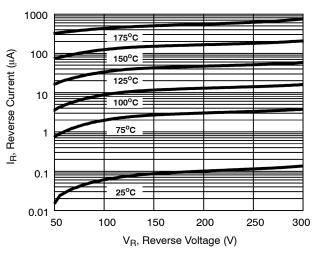


Figure 2. Reverse Current vs. Reverse Voltage

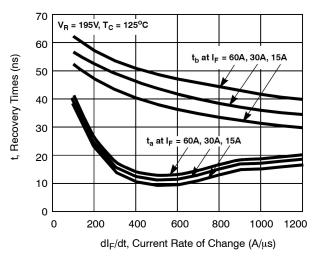


Figure 4. t_a and t_b Curves vs. dl_F/dt

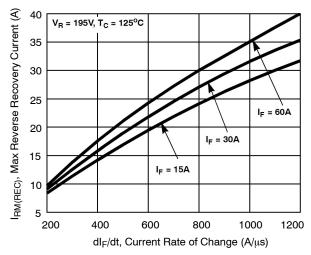


Figure 6. Maximum Reverse Recovery Current vs. dl_F/dt

TYPICAL PERFORMANCE CHARACTERISTICS (per leg) (continued)

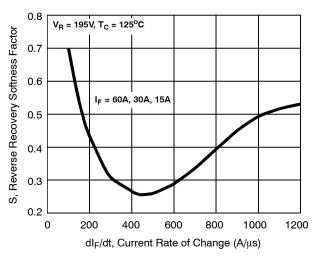


Figure 7. Reverse Recovery Softness Factor vs. dl_F/dt

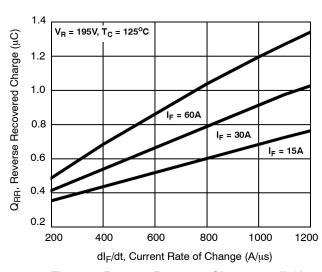


Figure 8. Reverse Recovery Charge vs. dl_F/dt

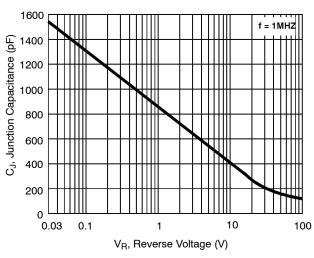


Figure 9. Junction Capacitance vs. Reverse Voltage

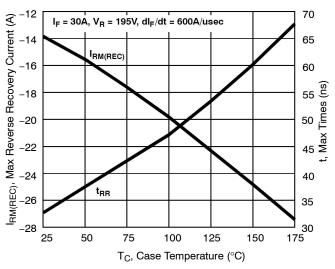


Figure 10. Maximum Reverse Recovery Current and t_{rr} vs. Case Temperature

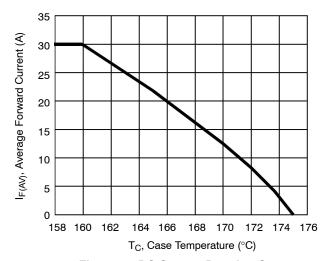


Figure 11. DC Current Derating Curve

TYPICAL PERFORMANCE CHARACTERISTICS (per leg) (continued)

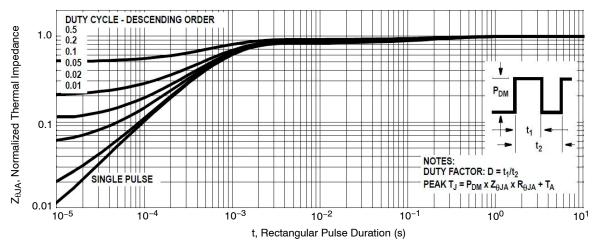


Figure 12. Normalized Maximum Transient Thermal Impedance

TEST CIRCUITS AND WAVEFORMS

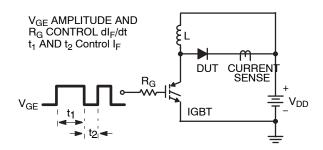


Figure 13. t_{rr} Test Circuit

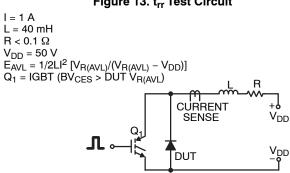


Figure 15. Avalanche Energy Test Circuit

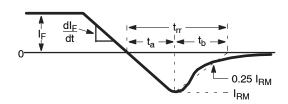


Figure 14. t_{rr} Waveforms and Definitions

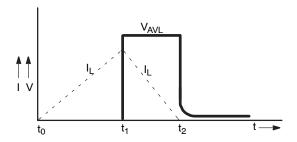
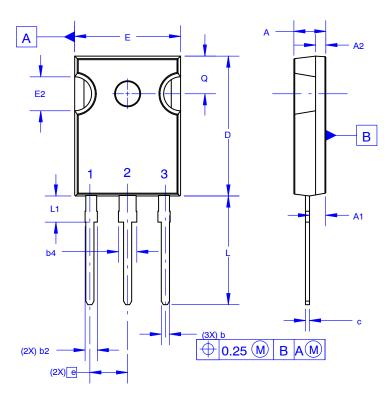


Figure 16. Avalanche Current and Voltage **Waveforms**

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TO-247-3LD SHORT LEAD

CASE 340CK ISSUE A





- A. DIMENSIONS ARE EXCLUSIVE OF BURRS, MOLD FLASH, AND TIE BAR EXTRUSIONS.
- B. ALL DIMENSIONS ARE IN MILLIMETERS.
- C. DRAWING CONFORMS TO ASME Y14.5 2009.
- D. DIMENSION A1 TO BE MEASURED IN THE REGION DEFINED BY L1.
- E. LEAD FINISH IS UNCONTROLLED IN THE REGION DEFINED BY L1.

GENERIC MARKING DIAGRAM*



XXXX = Specific Device Code

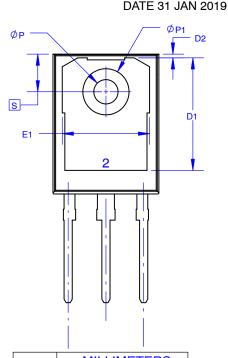
A = Assembly Location

Y = Year

WW = Work Week

ZZ = Assembly Lot Code

*This information is generic. Please refer to device data sheet for actual part marking. Pb-Free indicator, "G" or microdot "•", may or may not be present. Some products may not follow the Generic Marking.



DIM	MILLIMETERS			
DIIVI	MIN	NOM	MAX	
Α	4.58	4.70	4.82	
A1	2.20	2.40	2.60	
A2	1.40	1.50	1.60	
b	1.17	1.26	1.35	
b2	1.53	1.65	1.77	
b4	2.42	2.54	2.66	
С	0.51	0.61	0.71	
D	20.32	20.57	20.82	
D1	13.08	~	~	
D2	0.51	0.93	1.35	
E	15.37	15.62	15.87	
E1	12.81	~	~	
E2	4.96	5.08	5.20	
е	~	5.56	~	
L	15.75	16.00	16.25	
L1	3.69	3.81	3.93	
ØΡ	3.51	3.58	3.65	
ØP1	6.60	6.80	7.00	
Q	5.34	5.46	5.58	
S	5.34	5.46	5.58	

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